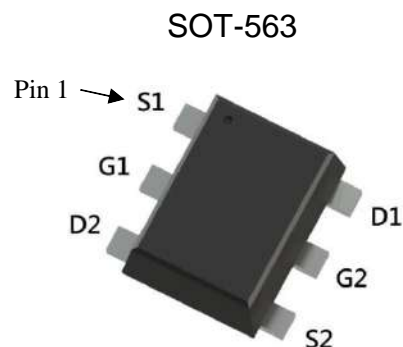


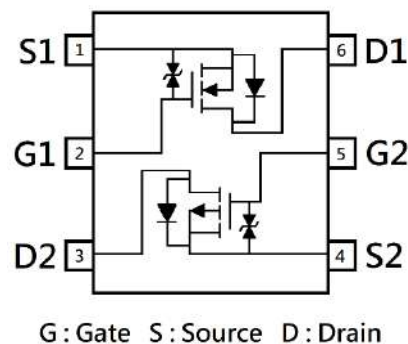
## N- AND P-Channel Enhancement Mode Power MOSFET

### Features:

- Low On Resistance
- Low Gate Charge
- RoHS compliant package
- ESD protected gate, typical 4kV (HBM)



	N-CH	P-CH
$BV_{DSS}$	20V	-20V
$I_D @ V_{GS}=(-)4.5V, T_A=25^\circ C$	0.83A	-0.52A
$R_{DS(ON)}$ typ. @ $V_{GS}=(-)4.5V$	0.32 $\Omega$	0.75 $\Omega$
$R_{DS(ON)}$ typ. @ $V_{GS}=(-)2.5V$	0.4 $\Omega$	0.9 $\Omega$
$R_{DS(ON)}$ typ. @ $V_{GS}=(-)1.8V$	0.7 $\Omega$	1.1 $\Omega$



### Ordering Information

Device	Package	Shipping
KWA300C02K	SOT-563 (Pb-free lead plating and halogen-free package)	3000 pcs / Tape & Reel

### Absolute Maximum Ratings (T<sub>A</sub>=25°C)

Parameter	Symbol	Limits		Unit
		N-CH	P-CH	
Drain-Source Voltage	V <sub>DS</sub>	20	-20	V
Gate-Source Voltage	V <sub>GS</sub>	±8	±8	
Continuous Drain Current @ V <sub>GS</sub> =(-)4.5V, T <sub>A</sub> =25°C	I <sub>D</sub>	0.83	-0.52	A
Continuous Drain Current @ V <sub>GS</sub> =(-)4.5V, T <sub>A</sub> =70°C		0.66	-0.42	
Pulsed Drain Current *a	I <sub>DM</sub>	3.32	-2.08	
Continuous Body Diode Forward Current @ T <sub>A</sub> =25°C	I <sub>S</sub>	0.42	-0.42	
ESD susceptibility *b	V <sub>ESD</sub>	4000	4000	V
Total Power Dissipation	P <sub>D</sub>	0.51		W
		0.33		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55~+150 °C	

### Thermal Data

Parameter	Symbol	Steady State	Unit
Thermal Resistance, Junction-to-ambient	R <sub>θJA</sub>	245	°C/W

Note:

\*a. Repetitive rating, pulse width limited by junction temperature T<sub>J</sub>(MAX)=150°C. Ratings are based on low frequency and low duty cycles to keep initial T<sub>J</sub>=25°C.

\*b. Human body model, 1.5kΩ in series with 100pF.

**N-Channel Electrical Characteristics (T<sub>A</sub>=25°C, unless otherwise specified)**

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
BV <sub>DSS</sub>	20	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA
V <sub>GS(th)</sub>	0.4	-	1.2		V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA
G <sub>FS</sub>	-	0.8	-	S	V <sub>DS</sub> =5V, I <sub>D</sub> =0.2A
I <sub>GSS</sub>	-	-	±10	μA	V <sub>GS</sub> =±8V, V <sub>DS</sub> =0V
I <sub>DSS</sub>	-	-	1		V <sub>DS</sub> =16V, V <sub>GS</sub> =0V
R <sub>DS(ON)</sub>	-	0.32	0.45	Ω	V <sub>GS</sub> =4.5V, I <sub>D</sub> =0.2A
	-	0.4	0.6		V <sub>GS</sub> =2.5V, I <sub>D</sub> =0.2A
	-	0.7	1.2		V <sub>GS</sub> =1.8V, I <sub>D</sub> =10mA
<b>Dynamic</b>					
C <sub>iss</sub>	-	33	-	pF	V <sub>DS</sub> =10V, V <sub>GS</sub> =0V, f=1MHz
C <sub>oss</sub>	-	15	-		
C <sub>rss</sub>	-	13	-		
Q <sub>g</sub> *1, 2	-	0.9	-	nC	V <sub>DS</sub> =20V, I <sub>D</sub> =0.6A, V <sub>GS</sub> =4.5V
Q <sub>gs</sub> *1, 2	-	0.2	-		
Q <sub>gd</sub> *1, 2	-	0.2	-		
t <sub>d(ON)</sub> *1, 2	-	5	-	ns	V <sub>DS</sub> =10V, I <sub>D</sub> =0.2A, V <sub>GS</sub> =4.5V, R <sub>GS</sub> =10Ω
t <sub>r</sub> *1, 2	-	17	-		
t <sub>d(OFF)</sub> *1, 2	-	20	-		
t <sub>f</sub> *1, 2	-	20	-		
	-		-		
<b>Source-Drain Diode</b>					
V <sub>SD</sub> *1	-	0.85	1.2	V	I <sub>S</sub> =0.2A, V <sub>GS</sub> =0V
t <sub>rr</sub>	-	5	-	ns	I <sub>F</sub> =0.5A, dI <sub>F</sub> /dt=100A/μs
Q <sub>rr</sub>	-	1	-	nC	

Note:

\*1. Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

\*2. Independent of operating temperature

**P-Channel Electrical Characteristics (T<sub>A</sub>=25°C, unless otherwise specified)**

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
BV <sub>DSS</sub>	-20	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =-250μA
V <sub>GS(th)</sub>	-0.4	-	-1.2		V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA
G <sub>FS</sub>	-	1	-	S	V <sub>DS</sub> =-5V, I <sub>D</sub> =-0.4A
I <sub>GSS</sub>	-	-	±10	μA	V <sub>GS</sub> =±8V, V <sub>DS</sub> =0V
I <sub>DSS</sub>	-	-	-1		V <sub>DS</sub> =-16V, V <sub>GS</sub> =0V
R <sub>DS(ON)</sub>	-	0.75	1.1	Ω	V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-0.2A
	-	0.9	1.5		V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-0.2A
	-	1.1	2.5		V <sub>GS</sub> =-1.8V, I <sub>D</sub> =-10mA
<b>Dynamic</b>					
C <sub>iss</sub>	-	45	-	pF	V <sub>DS</sub> =-10V, V <sub>GS</sub> =0V, f=1MHz
C <sub>oss</sub>	-	15	-		
C <sub>rss</sub>	-	8	-		
Q <sub>g</sub> *1, 2	-	1	-	nC	V <sub>DS</sub> =-20V, I <sub>D</sub> =-0.4A, V <sub>GS</sub> =-4.5V
Q <sub>gs</sub> *1, 2	-	0.2	-		
Q <sub>gd</sub> *1, 2	-	0.2	-		
t <sub>d(ON)</sub> *1, 2	-	11	-	ns	V <sub>DS</sub> =-10V, I <sub>D</sub> =-0.2A, V <sub>GS</sub> =-4.5V, R <sub>GS</sub> =10Ω
t <sub>r</sub> *1, 2	-	20	-		
t <sub>d(OFF)</sub> *1, 2	-	45	-		
t <sub>f</sub> *1, 2	-	35	-		
<b>Source-Drain Diode</b>					
V <sub>SD</sub> *1	-	-0.9	-1.2	V	I <sub>S</sub> =-0.4A, V <sub>GS</sub> =0V

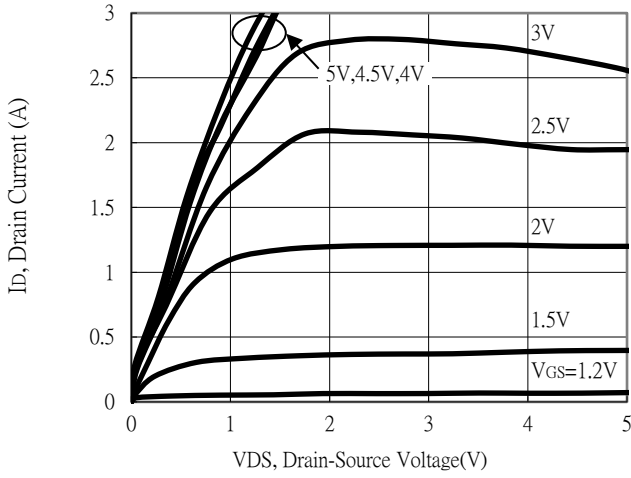
Note:

\*1. Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

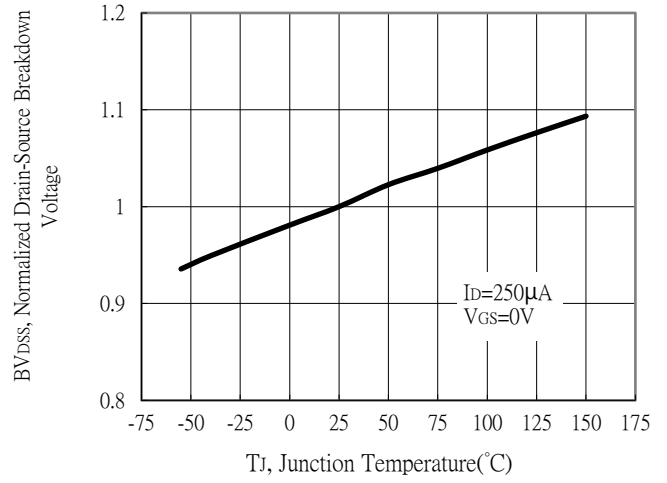
\*2. Independent of operating temperature

**Typical Characteristics : Q1( N-channel )**

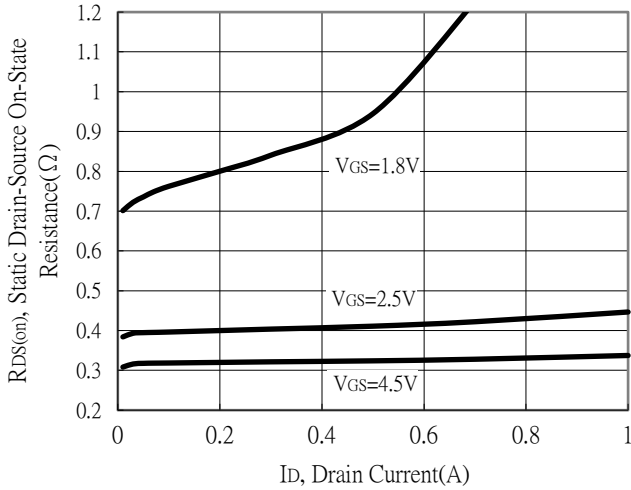
Typical Output Characteristics



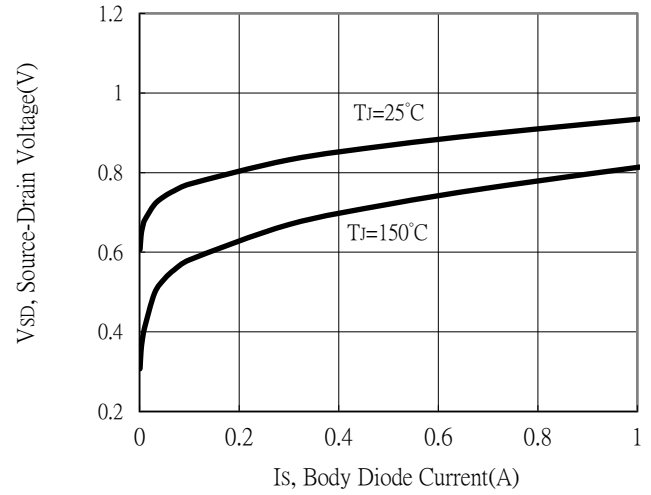
Breakdown Voltage vs Junction Temperature



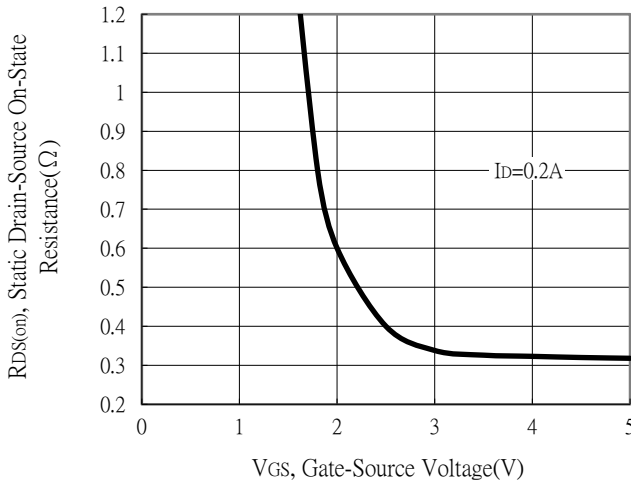
Static Drain-Source On-State resistance vs Drain Current



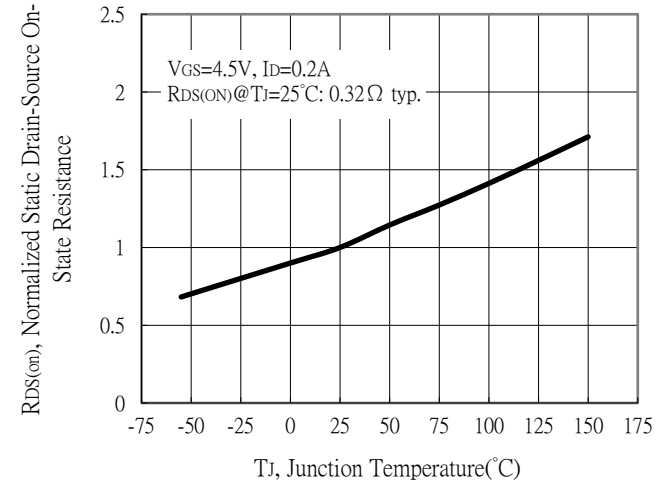
Body Diode Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

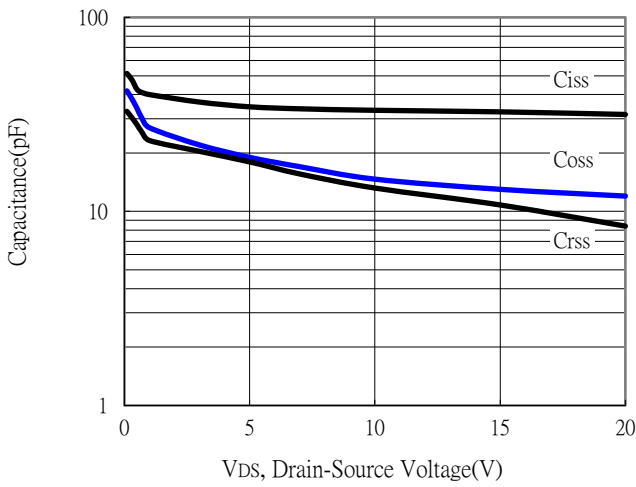


Drain-Source On-State Resistance vs Junction Temperature

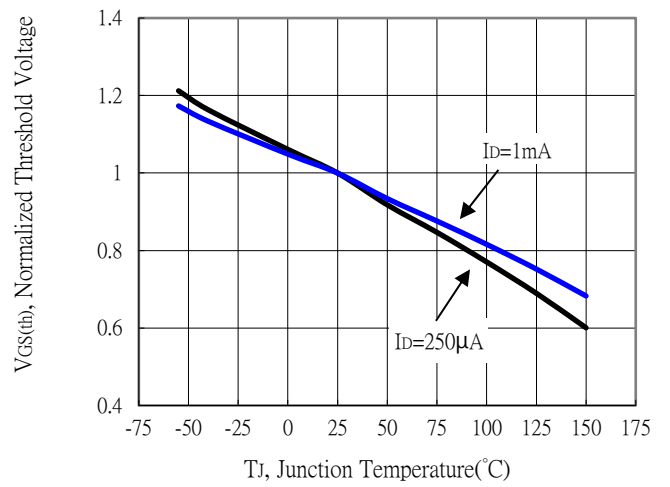


**Typical Characteristics (Cont.) : Q1( N-channel)**

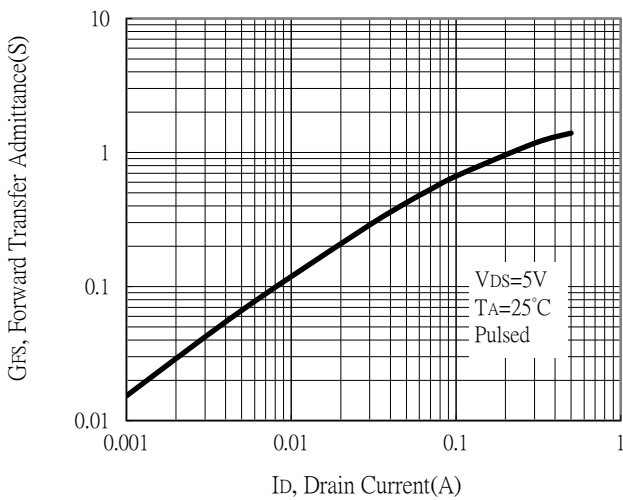
Capacitance vs Drain-to-Source Voltage



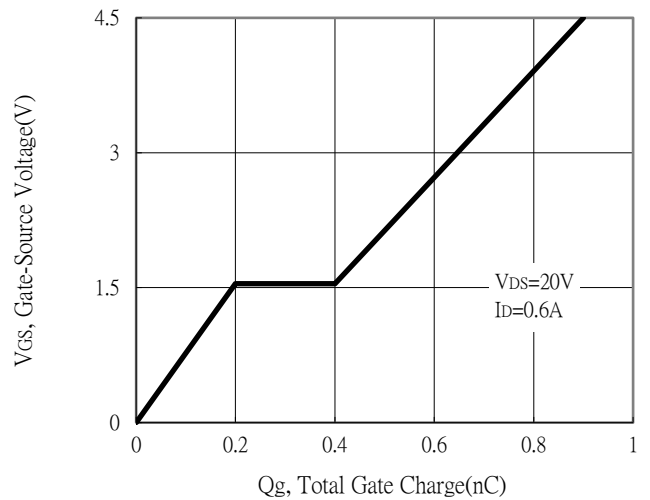
Threshold Voltage vs Junction Temperature



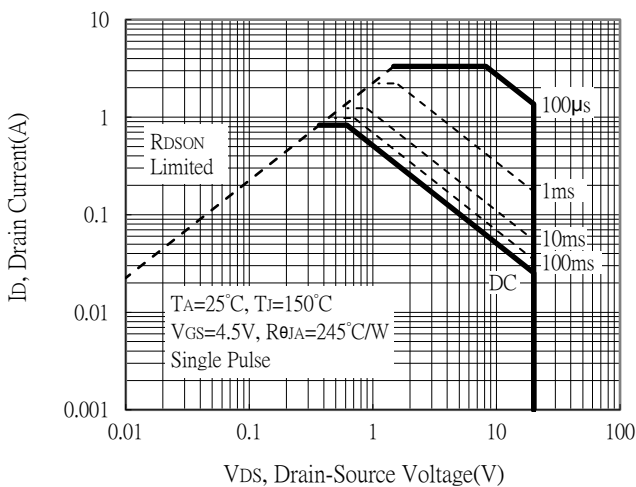
Forward Transfer Admittance vs Drain Current



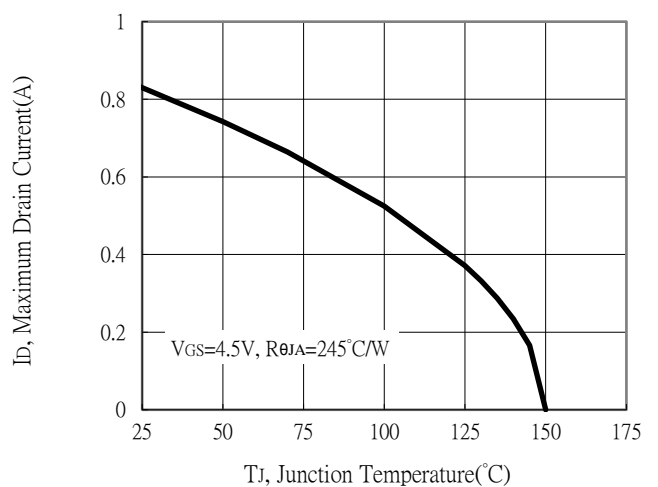
Gate Charge Characteristics



Maximum Safe Operating Area

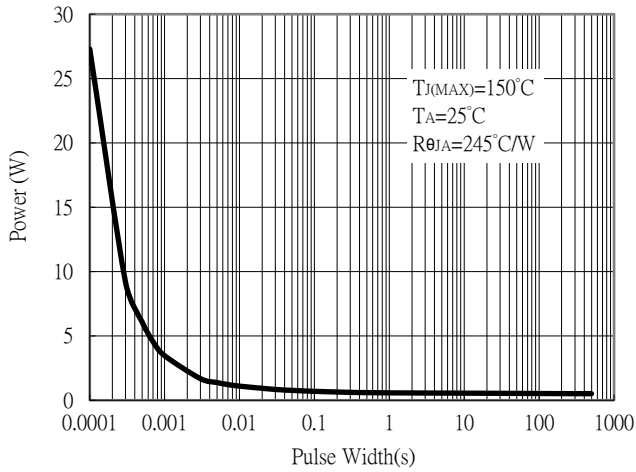


Maximum Drain Current vs Junction Temperature

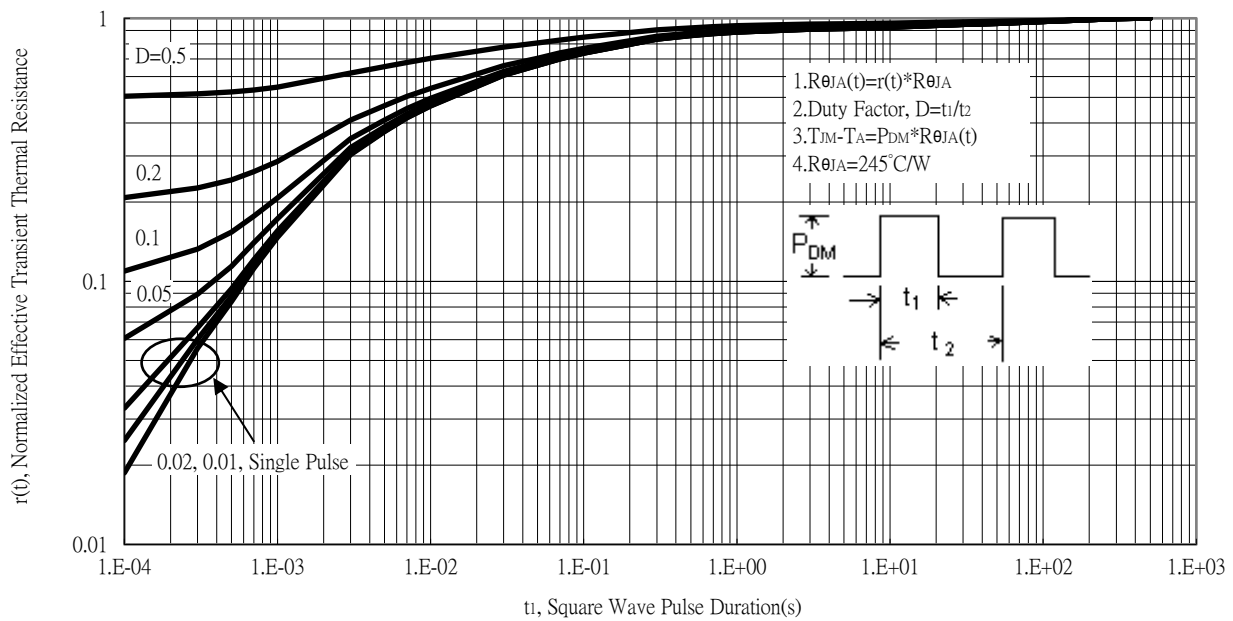


## Typical Characteristics (Cont.) : Q1( N-channel)

Single Pulse Power Rating, Junction to Ambient

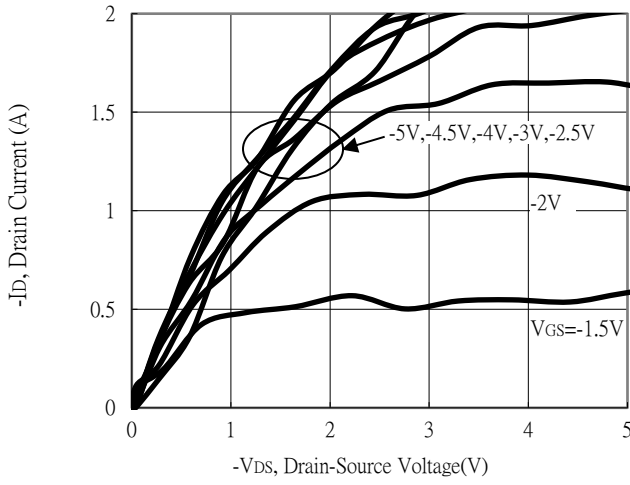


Transient Thermal Response Curves

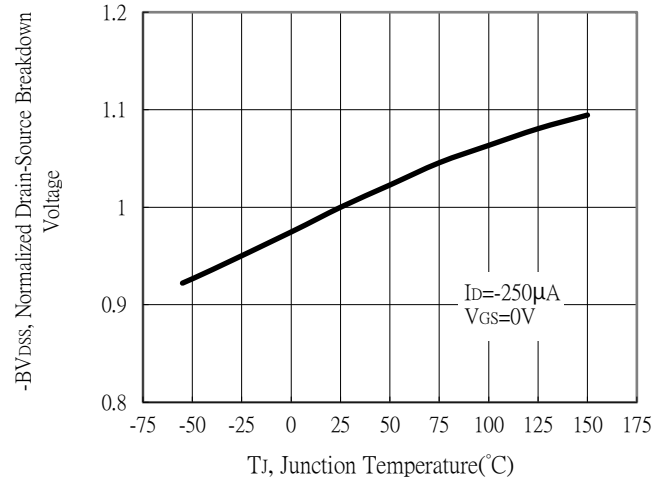


**Typical Characteristics : Q2( P-channel)**

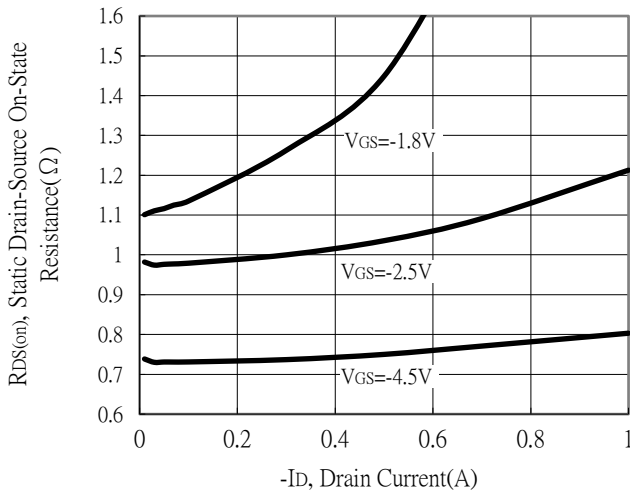
Typical Output Characteristics



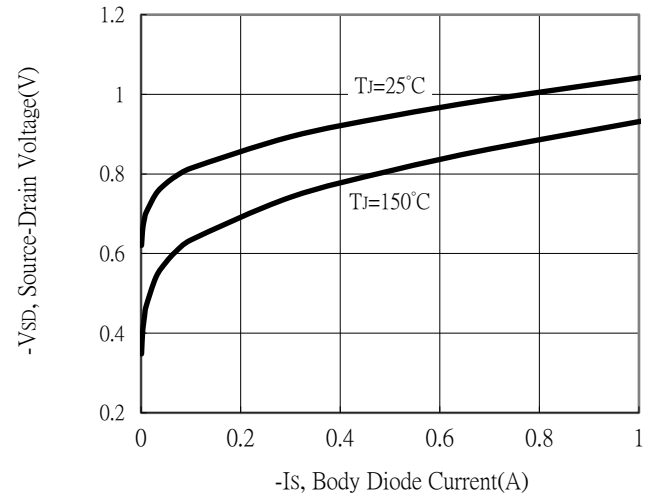
Breakdown Voltage vs Junction Temperature



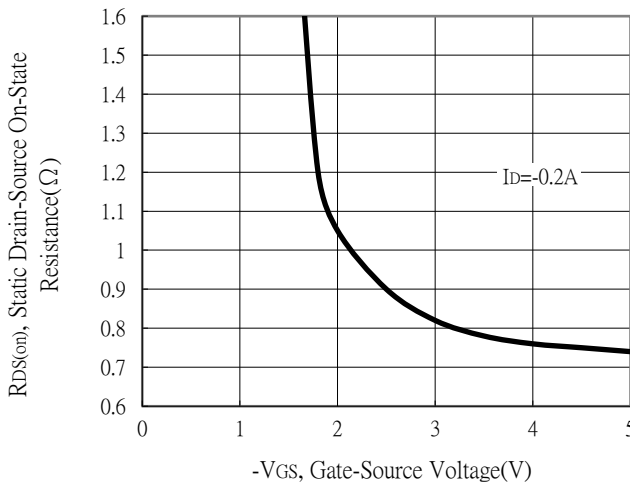
Static Drain-Source On-State resistance vs Drain Current



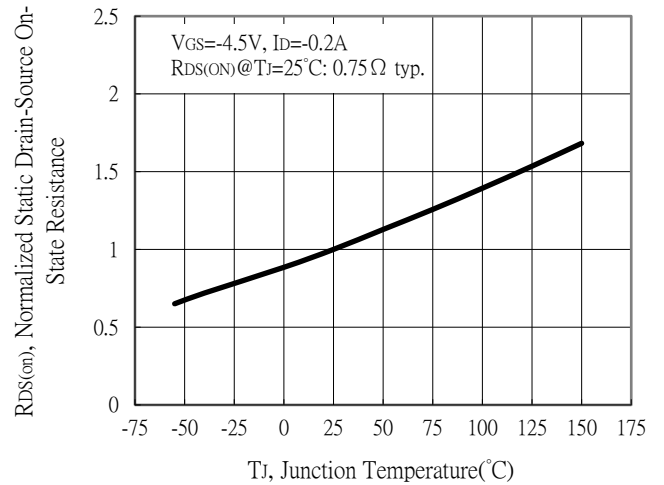
Body Diode Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage



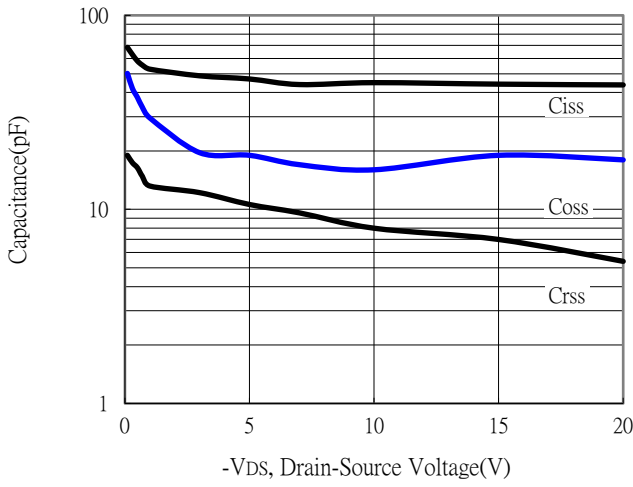
Drain-Source On-State Resistance vs Junction Temperature



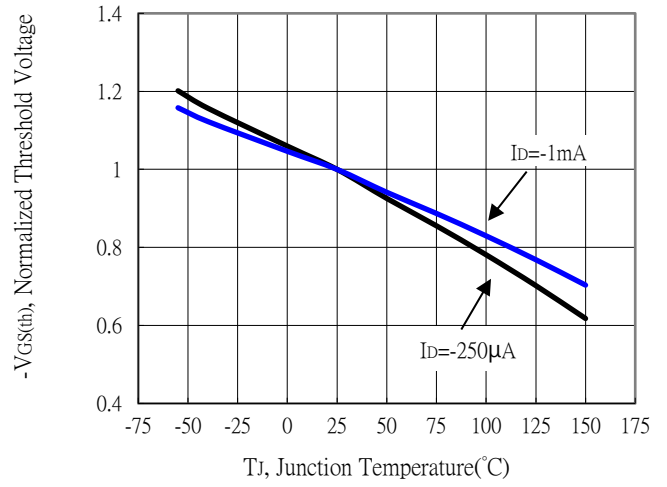


**Typical Characteristics (Cont.) : Q2(P-channel)**

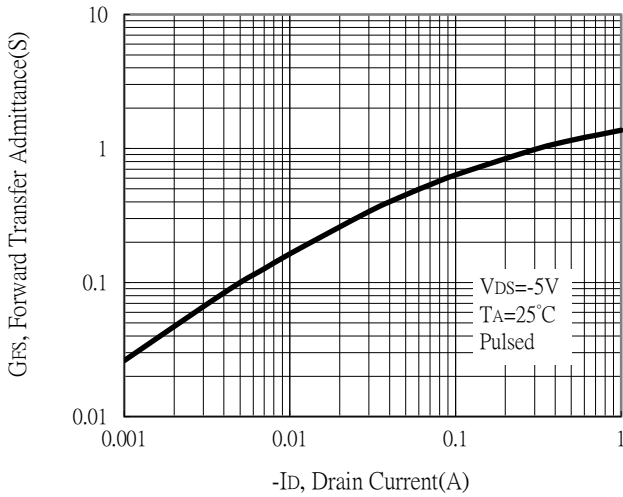
Capacitance vs Drain-to-Source Voltage



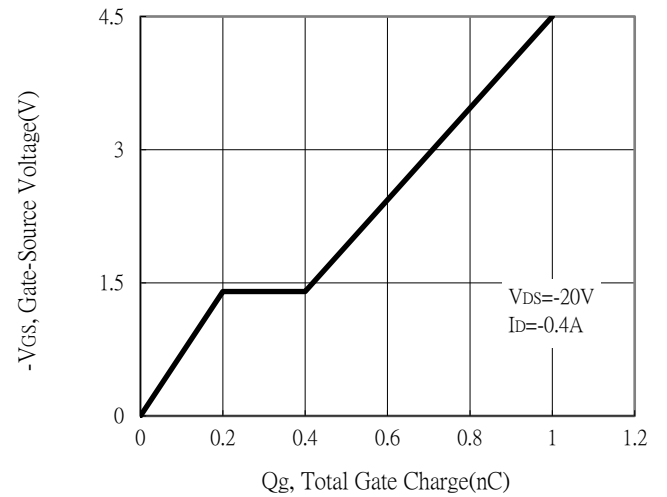
Threshold Voltage vs Junction Temperature



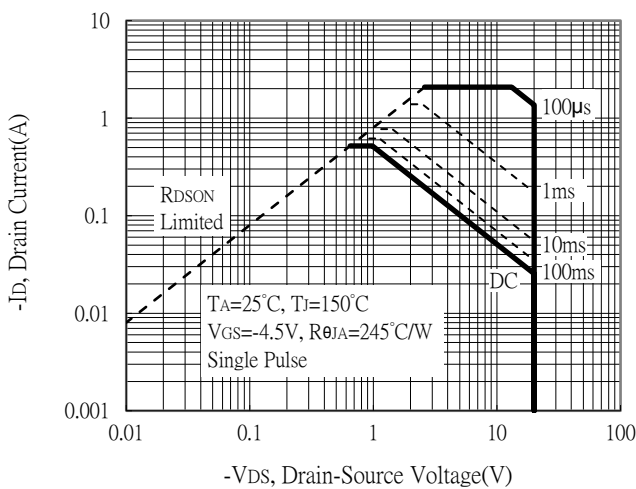
Forward Transfer Admittance vs Drain Current



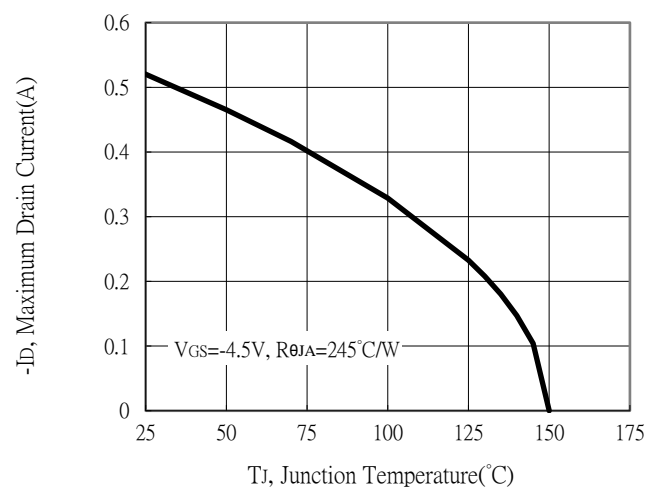
Gate Charge Characteristics



Maximum Safe Operating Area

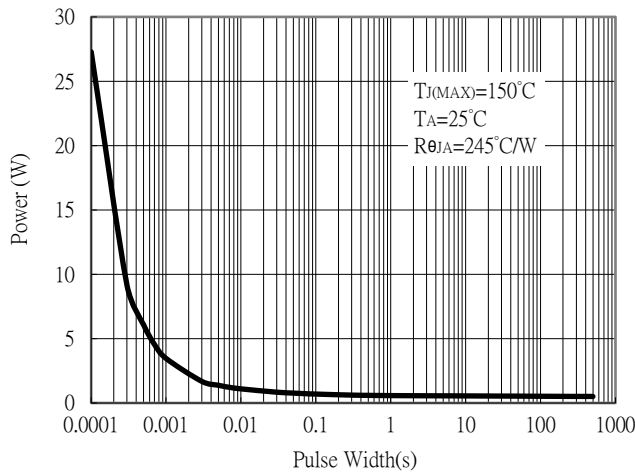


Maximum Drain Current vs Junction Temperature

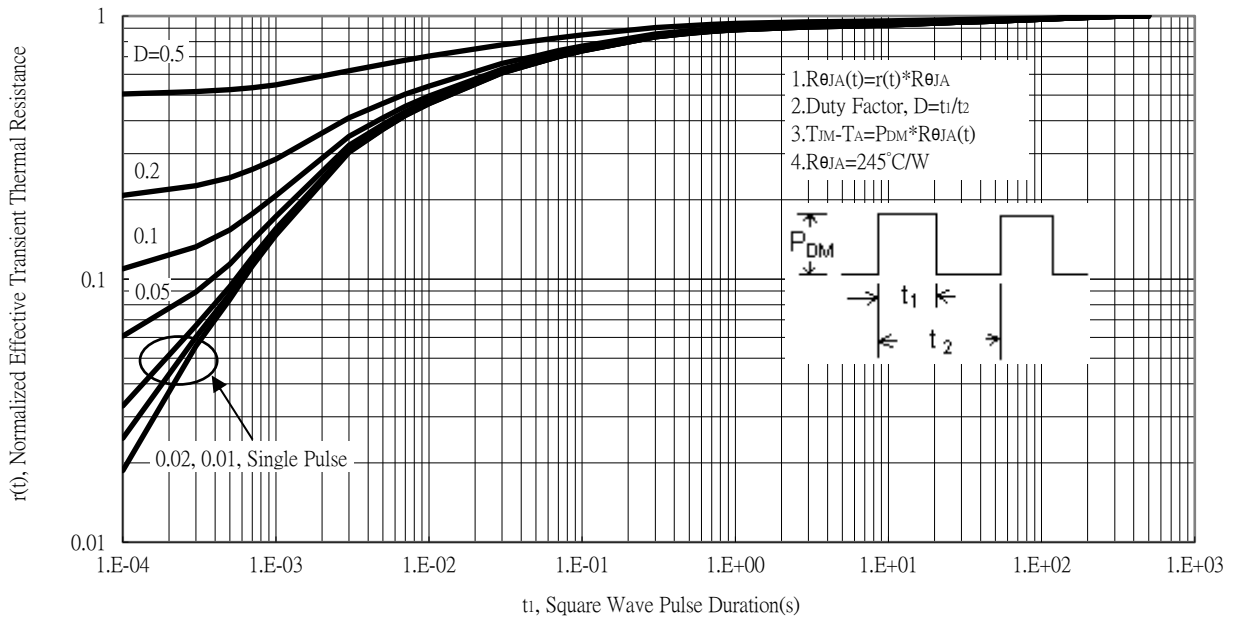


### Typical Characteristics (Cont.) : Q2(P-channel)

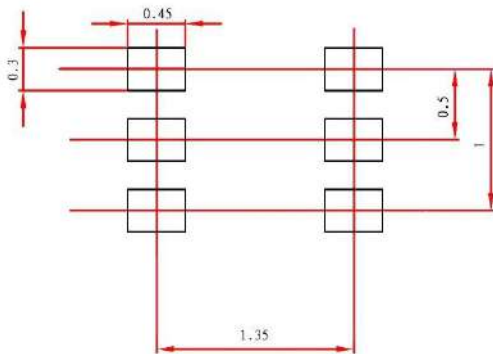
Single Pulse Power Rating, Junction to Ambient



Transient Thermal Response Curves

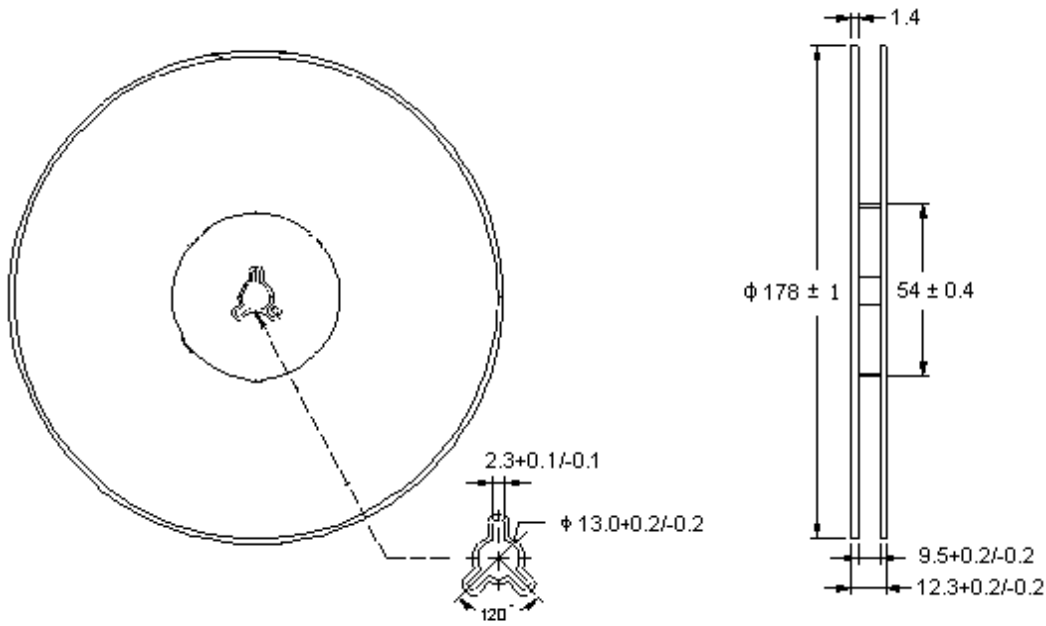


### Recommended Soldering Footprint



Unit : mm

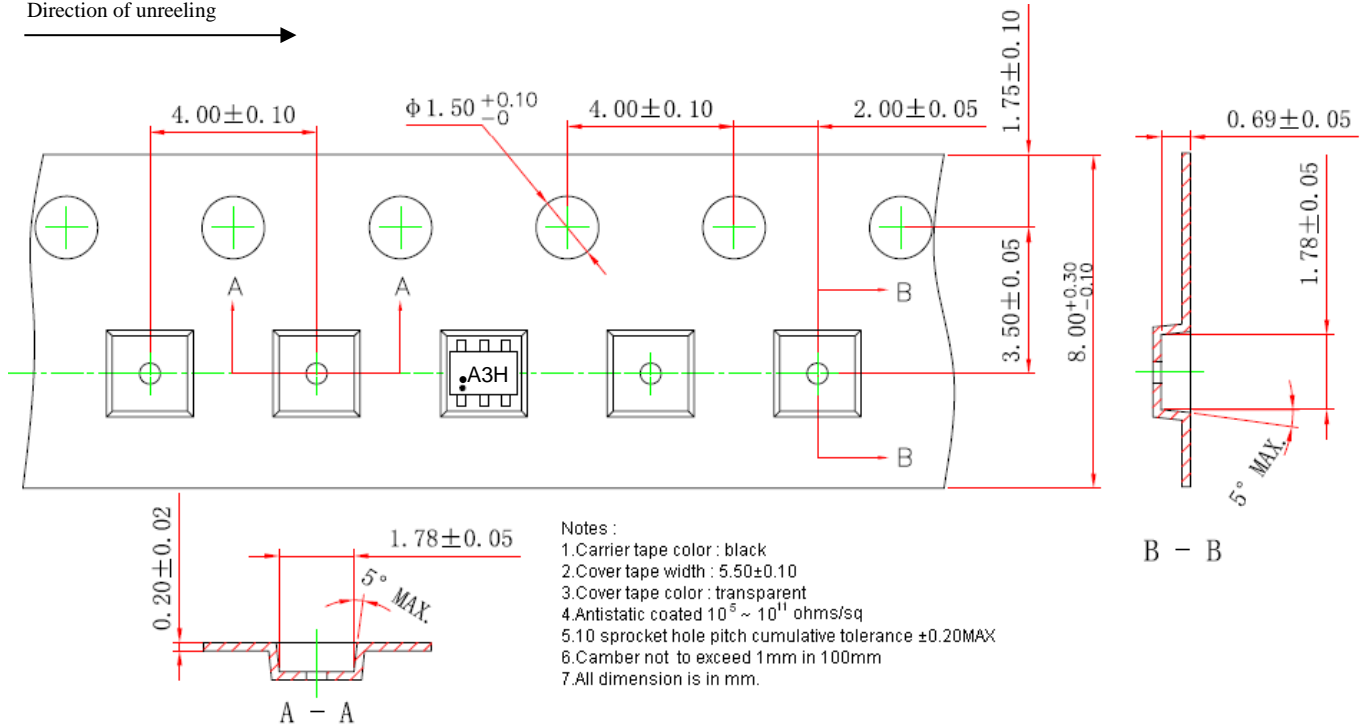
### Reel Dimension



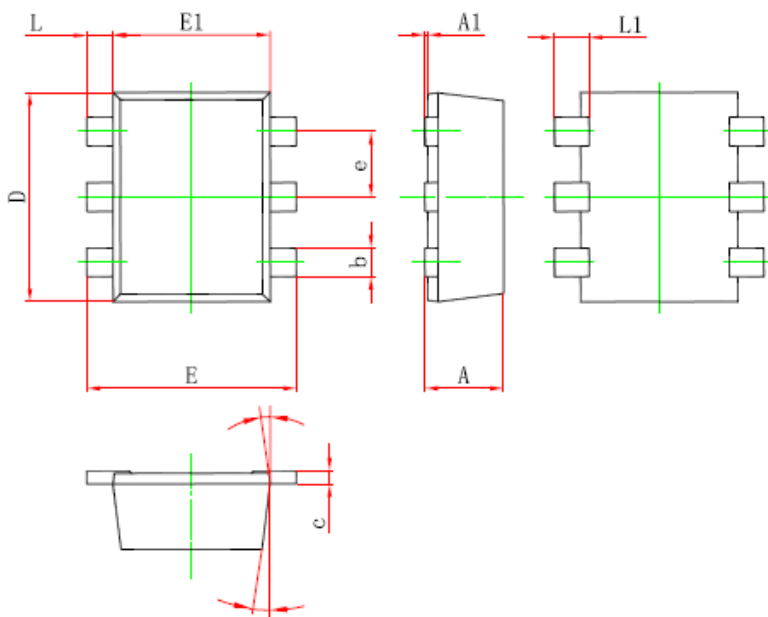
Unit: millimeter

### Carrier Tape Dimension

Direction of unreeling  $\rightarrow$

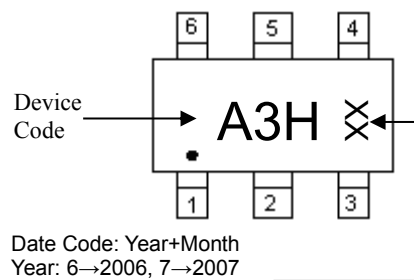


**SOT-563 Dimension**



6-Lead SOT-563 Plastic Surface Mounted Package

**Marking:**



Date Code: Year+Month  
 Year: 6→2006, 7→2007  
 Month: 1→1, 2→2, . . .  
 9→9, A→10, B→11, C→12

**Style:**

- Pin 1. Source1 (S1)
- Pin 2. Gate1 (G1)
- Pin 3. Drain2 (D2)
- Pin 4. Source2 (S2)
- Pin 5. Gate2 (G2)
- Pin 6. Drain1 (D1)

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.021	0.024	0.525	0.600	E1	0.043	0.051	1.100	1.300
A1	0.000	0.002	0.000	0.050	E	0.059	0.067	1.500	1.700
e	0.018	0.022	0.450	0.550	L	0.004	0.012	0.100	0.300
c	0.004	0.006	0.090	0.160	L1	0.008	0.016	0.200	0.400
D	0.059	0.067	1.500	1.700	θ	7° REF		7° REF	
b	0.007	0.011	0.170	0.270					